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SMX 3083.1
PATENT

C. H. Hwang
#11899
7.3.02

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of Youqi Wang, et al.
Serial No. 09/652,489 ✓
Filed August 31, 2000
Confirmation No. 3644
For SAMPLING PROBE
Examiner Elizabeth S. Quan

Art Unit 2899

June 21, 2002

AMENDMENT B

TO THE ASSISTANT COMMISSIONER FOR PATENTS,
Washington, D.C. 20231

SIR:

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TC 1700

In response to the Office action dated May 21, 2002,
please amend the above-identified application as follows:

In the Claims:

27. (amended) A probe as set forth in claim 26 wherein
the vent passage inlet is positioned adjacent the tip for
removing reactant from an area outside the recess.

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